

L3Harris Electronic Component Procurement Requirement Codes

Code	Description
EC01	Acceptance Test Results - Attributes Data. Seller shall include with each shipment a copy of the lot or item acceptance tests summary required by the applicable specification. The report shall include the principal specifications, including revision numbers or letters, which govern the production of the item. Test reports shall include the control identity (e.g. lot, heat lot, serial number) of the material or item tested. If Seller is not the original manufacturer, Seller shall furnish the manufacturer's test report as described above.
EC02	Acceptance Test Results - Variables Data. Seller shall include with each shipment a copy of the lot or item acceptance tests required by the applicable specification. The report shall include the principal specifications, including revision numbers or letters, which govern the production of the item. Where quantitative limits are established by the specification, the report shall indicate the actual values obtained during testing. Test reports shall include the control identity (e.g. lot, heat lot, serial number) of the material or item tested. If Seller is not the original manufacturer, Seller shall furnish the manufacturer's test report as described above.
EC03	X-Ray Data. Seller shall include with each shipment x-ray film copies or real-time x-ray images. The report shall include the principal specifications, including revision numbers or letters, which govern the production of the item. Test reports shall include the control identity (e.g. lot, heat lot, serial number) of the material or item tested. If Seller is not the original manufacturer, Seller shall furnish the manufacturer's documentation as described above.
EC04	Group A Quality Conformance Inspection Data. Seller shall include with each shipment a copy of the results of the lot or item Group A acceptance tests as required by the applicable device specification. Where quantitative limits are established by the specification, the report shall indicate the actual values obtained during testing. If Seller is not the original manufacturer, Seller shall furnish the manufacturer's test report as described above.
EC05	Group B/LAT (Lot Acceptance Test) Quality Conformance Inspection Data. Seller shall include with each shipment a copy of the results of the lot or item Group B acceptance tests as required by the applicable device specification. Where quantitative limits are established by the specification, the report shall indicate the actual values obtained during testing. If Seller is not the original manufacturer, Seller shall furnish the manufacturer's test report as described above.
EC06	Group C Quality Conformance Inspection Data. Seller shall include with each shipment a copy of the results of the lot or item Group C acceptance tests as required by the applicable device specification. Where quantitative limits are established by the specification, the report shall indicate the actual values obtained during testing. If Seller is not the original manufacturer, Seller shall furnish the manufacturer's test report as described above.
EC07	Group D Quality Conformance Inspection Data. Seller shall include with each shipment a copy of the results of the lot or item Group D acceptance tests as required by the applicable device specification. Where quantitative limits are established by the specification, the report shall indicate the actual values obtained during testing. If Seller is not the original manufacturer, Seller shall furnish the manufacturer's test report as described above.
EC08	DPA Samples - Device Elements. Seller shall include with each shipment device element samples as required per the applicable specification for Destructive Physical Analysis. Device element samples may be shipped prior to lot acceptance testing (ex. Group B) but not prior to completion of 100% screening test requirements per the applicable specification.
EC09	Hot Solder Dip. Prior to shipment by the Seller, all devices shall have been subjected to the Hot Solder Dip requirements of MIL-PRF-19500 para H.4.3 and Table H-I for discrete semiconductors and MIL-PRF-38535 Appendix A, paragraphs A.3.5.6.3.2 and A.3.5.6.3.4 for microcircuits.
EC10	Waffle packaging. Prior to shipment by the Seller, all devices shall be loaded into appropriately sized waffle packs which will provide protection against deterioration and physical damage during shipment and also meet the ESD (Electrostatic Discharge) packaging requirements of Q404.
EC11	Lot Date Code Less Than 4 Years. Seller shall provide all devices with a manufacturer's Lot Date Code that is less than 4 years from date of Purchase Order.
EC12	Single Lot Date Code. The full quantity of each part number provided under this purchase order shall have a single lot date code. Seller will obtain the written approval of L3Harris's authorized purchasing representative prior to shipping goods that do not meet this single lot date code requirement. In the event that the L3Harris's purchasing representative provides authorization in writing to ship mixed lot date codes, the seller shall provide a copy of the L3Harris written authorization with the shipping document. When mixed lot date codes are authorized, the shipper shall list individual lot date codes and quantity. Multiple lot date codes shall not be co-mingled. In addition, the individual part containers shall be marked with the quantity and lot date code.
EC13	Groups A, B and C Quality Conformance Inspection Data. Seller shall include with each shipment a copy of the results of the lot or item Groups A B and C acceptance tests as required by the applicable device specification. Where quantitative limits are established by the specification, the report shall indicate the actual values obtained during testing. If Seller is not the original manufacturer, Seller shall furnish the manufacturer's test report as described above.